

Search Notes

Application/Control No.

10/530,656

Examiner

HUYEN D. LE

Applicant(s)/Patent under
Reexamination

MEHR ET AL.

Art Unit

2615

SEARCHED

Class	Subclass	Date	Examiner
381'	312, 322, 324, 328, 330	3/23/2007	HL
174	33		HL
	34		HL
	250		HL
	261		HL
439	77		HL
361	749		HL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner